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High-Pressure High-Temperature XAFS Investigation on HgTe

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Abstract X-ray absorption measurements at the L₃ edge of Hg in solid and liquid HgTe have been performed under high-temperature and high-pressure up to 1000 K and 3 GPa using a large volume Paris-Edinburgh press. EXAFS spectra have been analyzed with GNXAS approach. The pressure dependencies of the nearest neighbor distance and the bond variance at room temperature as well as their variation with temperature at 0.6 GPa have been obtained. The temperature dependence of the bond variance has been fitted to the Einstein model and is consistent to the decrease of the bulk modulus with increasing temperature, which has recently been shown to occur by an x-ray diffraction study.

1. INTRODUCTION

The pressure-temperature phase diagram and equation of state of HgTe have recently been precisely redetermined by x-ray diffraction[1] HgTe has a zinc-blend structure at ambient pressure and it transforms to a cinnabar structure at 1.5 GPa at 300 K. The study revealed anomalous features of HgTe: (1) The bulk modulus, B, of zinc-blend phase decreases with increasing temperature. In addition, the magnitude of the temperature derivative of B, dB/dT, increases with increasing pressure. (2) The melting curve of the cinnabar phase is almost isothermal. Anomalies in liquid structure are expected under high pressure.

XAFS is a powerful tool to investigate local atomic structures for both solid and liquid phases. This method was successfully applied to high pressure studies, including crystalline HgTe[2]. It is also known that temperature dependence of EXAFS spectra gives information on vibrational properties. There are, however, very few XAFS studies under high pressure and high temperature conditions[3] mainly due to technical difficulties.

Recently a new type of large volume press, Paris-Edinburgh cell, has been developed for neutron diffraction experiments[4]. Its compactness enables us to install it in conventional XAFS beamlines. In this study we carried out x-ray absorption measurements at the L₃ edge of Hg in solid and liquid HgTe up to 3 GPa and 1000 K using this press.

2. EXPERIMENTAL

HgTe crystal was finely ground in a ball-milling and then mixed with fine BN powder in a weight ratio of 1:10. The high pressure chamber consists of two tungsten carbide opposed anvils which have conical hollows. The sample was put into a 2.0-mm-o.d., 1.5-mm-i.d. tube-type graphite heater, inside a gasket made of mixture of Boron and Epoxy. X-ray absorption measurements were performed by transmission method at W21 beamline at LURE. Synchrotron radiation from a superconducting wiggler device was monochromatized by a Si(111) double crystal monochromator. The beam was focused vertically by a mirror and horizontally by the 2nd crystal of the monochromator. The beam size was reduced to 0.5 mm in height and 1.0 mm in width by two slits. The x-ray beam passed through the aperture between the two anvils. The intensities of incident and transmitted x-ray beams were monitored by an ionization chamber and a photo diode detector, respectively.

3. RESULTS AND DISCUSSION

EXAFS spectra of solid and liquid HgTe as a function of temperature and pressure have been analyzed using an ab-initio multiple-scattering data-analysis method (GNXAS)[5]. Data-analysis was performed taking into account double-electron excitation channels into the atomic background[6]. A reference Hg L₃ EXAFS spectrum recorded at ambient pressure and temperature at the D42 beamline at LURE was used to test the accuracy of the model signal. Interatomic distance and bond variance were found to be $R = 2.782 \, \text{Å}$ and $\sigma^2 = 0.9 \times 10^{-2} \, \text{Å}^2$. The $S_0^2$ amplitude factor associated was found to be $S_0^2 \sim 0.84$ and kept fixed in the successive analysis of the high-pressure and high-temperature EXAFS spectra. The room-temperature high-pressure results up to 3 GPa are in good agreement with an x-ray diffraction study[1] and an XAFS study in a diamond anvil cell[2].

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In Fig. 1, the EXAFS spectra of HgTe at 0.6 GPa are shown for increasing temperatures, from the bottom to the top. Solid HgTe was measured at 300, 540, 640 and 760 K, as indicated in Fig. 1. The first-neighbor Hg-Te two-body signal dominates the EXAFS spectra even at room temperature. The quality of the spectra decreases at high temperatures, and data at high wave-vector values were not considered at 640 and 760 K. The coordination number was kept fixed to the known crystallographic value.

Figure 2 shows the variation of the bond variance, \( \sigma^2 \), as a function of temperature. The estimated error bars shown in the Fig. 2 are quite large due to poor signal-to-noise ratio. However, the trend of the temperature dependence can still be revealed. The dashed line indicates the result of a fit using the Einstein model[7]. The obtained \( \omega_2 \) was 95 cm\(^{-1}\). It is in agreement with the optical phonon frequency measured at 0 GPa, \( \omega_{\text{opt}} = 117 \ \text{cm}^{-1} \) and \( \omega_{\text{opt}} = 135 \ \text{cm}^{-1}\)[8]. There is, however, discrepancy between the experimental points and the theoretical curve. To improve the fit we took the temperature dependence of the Einstein frequency into consideration. We estimated it from the temperature dependence of \( B \), which was determined by a recent high-pressure x-ray diffraction study[1]. Actually the study revealed that \( B \) decreased by 23 % from 300 K to 800 K at 0.6 GPa. For cubic materials, a square-root law holds between Debye frequency, \( \omega_D \), and \( B[9] \). We assumed that \( \omega_2 \) has the same temperature dependence as \( \omega_D \).

The solid line in the Fig. 2 shows the result of the fit. The agreement is better than with the simple model. The fitting parameter, \( \omega_2 \) at 300 K, is found to be 110 cm\(^{-1}\).

The EXAFS spectrum of liquid HgTe at 1000 K is shown on the top of Fig. 1. The only clear feature is the peak at about 4.5 Å\(^{-1}\). The position and the height of this peak are sufficient to obtain an estimate of the Hg-Te mean distance and variance. A clear broadening of the first-neighbor distribution is then measured, although coordination number can float between 4 and 6 obtaining always reasonable fits. It is in agreement with the value, 6 \pm 0.8, obtained by a recent neutron diffraction study on liquid HgTe at 0 GPa[10]. The bond length, 2.8 \pm 0.06 Å, has the same value than in the solid but is shorter than that determined by the neutron diffraction study.

This study shows that the XAFS experiments under high-pressure and high-temperature conditions using a large anvil cell are possible. They give unique structural and vibrational information which other methods cannot access under high-pressure high-temperature conditions.

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References

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